Product data sheet

1. General description

2x30A, 300V dual ultrafast power diode in a TO247 plastic package.

2. Features and benefits

- · Low forward voltage drop
- Fast Switching
- · Soft recovery characteristics
- · High thermal cycling performance
- Low thermal resistance

3. Applications

- Telecom power supplies
- Welding machines
- Secondary rectification in SMPS

4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit		
Absolute	Absolute maximum rating								
V_R	reverse voltage	DC		-	-	300	V		
$I_{F(AV)}$	average forward current	δ = 0.5; T _{mb} ≤ 103 °C; square-wave pulse; per diode; Fig. 1; Fig. 2; Fig. 3		-	-	30	А		
I _{FSM}	non-repetitive peak forward current	t_p = 10 ms; $T_{j(init)}$ = 25 °C; sine-wave pulse; per diode; Fig. 4		-	-	300	А		
		t_p = 8.3 ms; $T_{j(init)}$ = 25 °C; sine-wave pulse; per diode		-	-	330	А		
Static ch	aracteristics								
V _F	forward voltage	$I_F = 30 \text{ A}; T_j = 25 \text{ °C}; \text{ per diode}; Fig. 6$		-	1	1.25	V		
		I _F = 30 A; T _j = 150 °C; per diode; <u>Fig. 6</u>		-	0.85	1	V		
Dynamic	Dynamic characteristics								
t _{rr}	reverse recovery time	$I_F = 1 \text{ A}$; $V_R = 30 \text{ V}$; $dI_F/dt = 50 \text{ A/}\mu\text{s}$; $T_j = 25 \text{ °C}$; Fig. 7		-	-	50	ns		

5. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	A1	anode 1		
2	K	cathode	$\parallel \circ \circ \parallel$	A1
3	A2	anode 2		K sym125
mb	К	mounting base; connected to cathode	1 2 3	sym125

6. Ordering information

Table 3. Ordering information

Type number	Package Name	Orderable part number	Packing method	Small packing quantity	Package version	Package issue date
BYV430W-300P	TO247	BYV430W-300PQ	Tube	30	SOT429 (L)	25-Mar-2013
					TO247P (P)	31-Mar-2023

7. Marking

Table 4. Marking codes

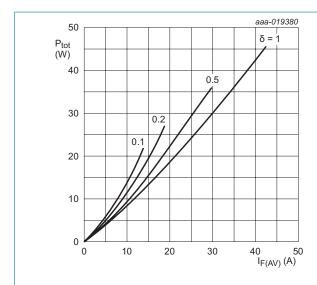
Type number	Marking codes		
	Assembly factory: L	Assembly factory: P	
BYV430W-300P	BYV430W 300P PJLxxxx xx	BYV430W 300P PJPxxxx xx	
		1 01 7777 77	

8. Limiting values

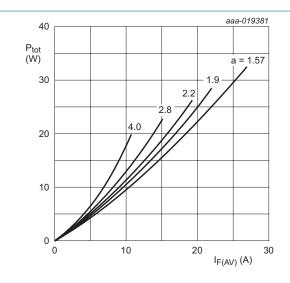
Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{RRM}	repetitive peak reverse voltage		-	300	V
V_{RWM}	crest working reverse voltage		-	300	V
V_R	reverse voltage	DC	-	300	V
I _{F(AV)}	average forward current	$δ = 0.5$; $T_{mb} \le 103$ °C; square-wave pulse; per diode; Fig. 1; Fig. 2; Fig. 3	-	30	А
$I_{O(AV)}$	average output current	δ = 0.5; T _{mb} ≤ 103 °C; square-wave pulse; both diodes conducting	-	60	А
I _{FRM}	repetitive peak forward current	δ = 0.5 ; t_p = 25 µs; square-wave pulse; per diode	-	60	Α
I _{FSM}	non-repetitive peak forward current	t_p = 10 ms; $T_{j(init)}$ = 25 °C; sine-wave pulse; per diode; Fig. 4	-	300	А
		t_p = 8.3 ms; $T_{j(init)}$ = 25 °C; sine-wave pulse; per diode	-	330	А
T _{stg}	storage temperature		-55	175	°C
T _j	junction temperature		-	175	°C



$$\begin{split} & I_{\text{F(AV)}} = I_{\text{F(RMS)}} \times \sqrt{\delta} \\ & V_o = 0.817 \text{ V}; \text{ R}_s = 0.006 \text{ }\Omega \\ \text{Fig. 1. Forward power dissipation as a function of average forward current; square waveform; } \\ & \text{maximum values; per diode} \end{split}$$



a = form factor = $I_{F(RMS)}/I_{F(AV)}$ V_o = 0.817 V; R_s = 0.006 Ω

Fig. 2. Forward power dissipation as a function of average forward current; sinusoidal waveform; maximum values; per diode

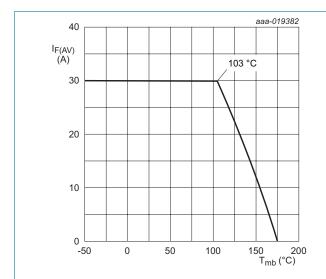


Fig. 3. Average forward current as a function of mounting base temperature; maximum values; per diode

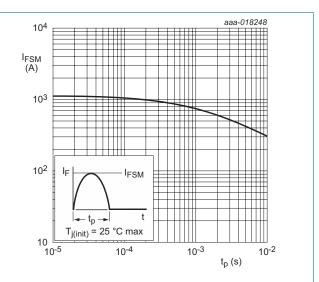


Fig. 4. Non-repetitive peak forward current as a function of pulse width; sinusoidal waveform; maximum values; per diode

9. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to	with heatsink compound; per diode; Fig. 5	-	0.8	2	K/W
	mounting base	with heatsink compound; both diodes conducting	-	-	1.2	K/W
R _{th(j-a)}	thermal resistance from junction to ambient free air	in free air	-	45	-	K/W

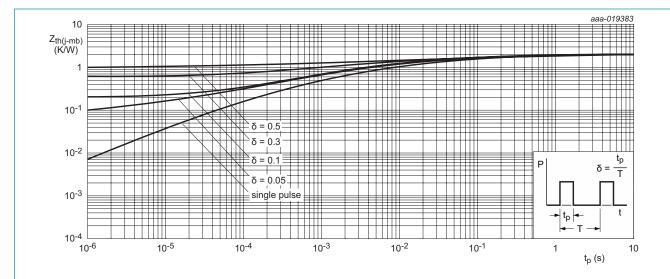
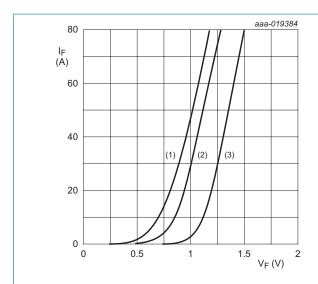


Fig. 5. Transient thermal impedance from junction to mounting base as a function of pulse duration; maximum values; per diode

10. Characteristics

Table 7 Characteristics

Symbol	Parameter	Conditions	N	lin	Тур	Max	Unit
Static ch	aracteristics						
V _F	forward current	I _F = 30 A; T _j = 25 °C; <u>Fig. 6</u>	-		1	1.25	V
		I _F = 30 A; T _j = 150 °C; <u>Fig. 6</u>	-		0.85	1	V
I _R	reverse current	V _R = 300 V; T _j = 25 °C	-		0.4	10	μA
		V _R = 300 V; T _j = 150 °C	-		-	500	μA
Dynamic	characteristics		'			1	
t _{rr}	reverse recovery time	$I_F = 1 \text{ A}; V_R = 30 \text{ V}; dI_F/dt = 50 \text{ A/}\mu\text{s};$ $T_j = 25 \text{ °C}; Fig. 7$	-		-	50	ns
		$I_F = 30 \text{ A}; V_R = 200 \text{ V}; dI_F/dt = 200 \text{ A/}\mu\text{s};$ $T_j = 25 \text{ °C}; Fig. 7$	-		33	-	ns
		$I_F = 30 \text{ A}; V_R = 200 \text{ V}; dI_F/dt = 200 \text{ A}/\mu\text{s};$ $T_j = 125 \text{ °C}; Fig. 7$	-		62	-	ns
I _{RM} peak reverse recovery current		$I_F = 30 \text{ A}; V_R = 200 \text{ V}; dI_F/dt = 200 \text{ A/}\mu\text{s};$ $T_j = 25 \text{ °C}; Fig. 7$	-		5.3	-	А
		$I_F = 30 \text{ A}; V_R = 200 \text{ V}; dI_F/dt = 200 \text{ A/}\mu\text{s};$ $T_j = 125 \text{ °C}; Fig. 7$	-		10.5	-	А
Q _r	reverse charge	$I_F = 30 \text{ A}; V_R = 200 \text{ V}; dI_F/dt = 200 \text{ A/}\mu\text{s};$ $T_j = 25 \text{ °C}; Fig. 7$	-		89	-	nC
		$I_F = 30 \text{ A}; V_R = 200 \text{ V}; dI_F/dt = 200 \text{ A}/\mu\text{s};$ $T_i = 125 \text{ °C}; Fig. 7$	-		337	-	nC



 V_o = 0.817 V; R_s = 0.006 Ω (1) T_j = 150 °C; typical values

(2) T_i = 150 °C; maximum values

(3) T_i = 25 °C; maximum values



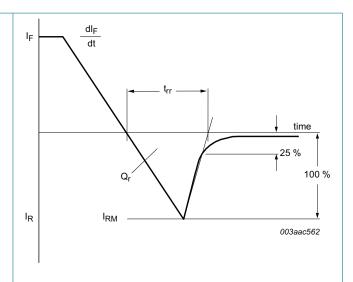
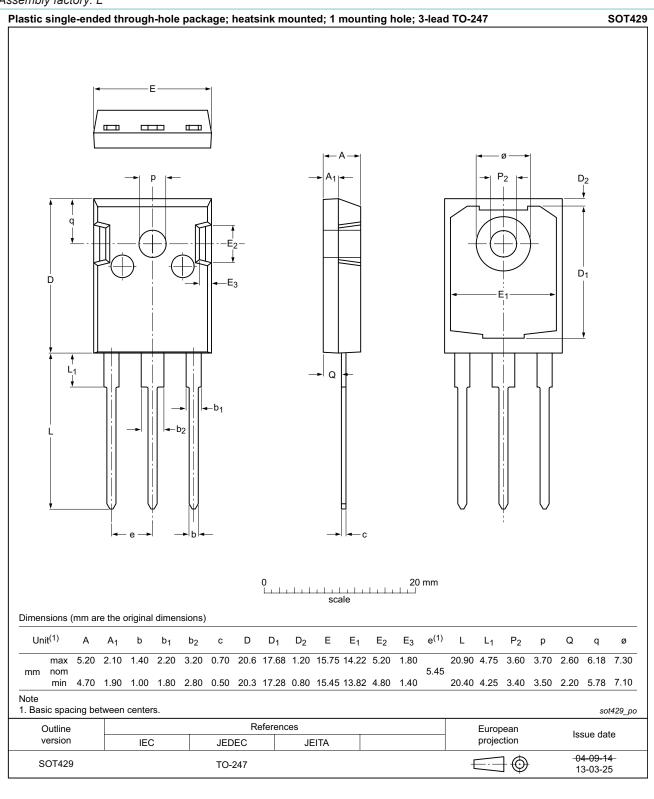


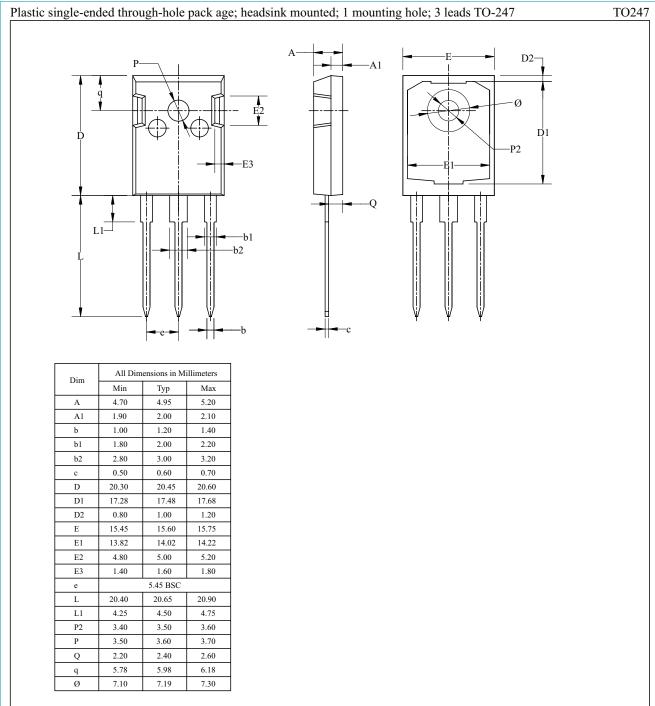
Fig. 7. Reverse recovery definitions; ramp recovery

11. Package outline

Assembly factory: L



Assembly factory: P



12. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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